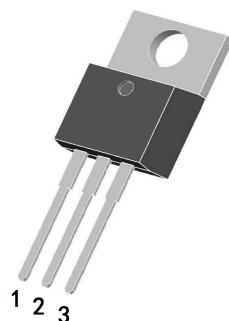


68V N-Channel Mosfet

FEATURES

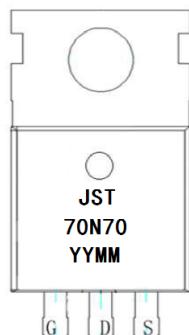
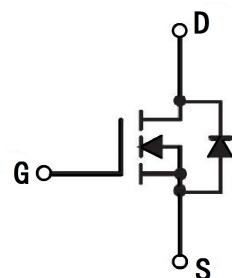
- $R_{DS(ON)} \leq 9\text{m}\Omega$ (7.5mΩ Typ.)
@ $V_{GS}=10\text{V}$

TO-220C

1. GATE
2. DRAIN
3. SOURCE

APPLICATIONS

- Load Switch
- PWM Application
- Power management

MARKING**N-CHANNEL MOSFET**

YYMM:Date Code(year&month)

MAXIMUM RATINGS ($T_c=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter		Max.	Units
V_{DSS}	Drain-Source Voltage		68	V
V_{GSS}	Gate-Source Voltage		± 20	V
I_D	Continuous Drain Current	$T_c = 25^\circ\text{C}$	80	A
		$T_c = 100^\circ\text{C}$	52	A
I_{DM}	Pulsed Drain Current ^{note1}		320	A
E_{AS}	Single Pulsed Avalanche Energy ^{note2}		110	mJ
P_D	Power Dissipation	$T_c = 25^\circ\text{C}$	103	W
R_{QJC}	Thermal Resistance, Junction to Case		1.46	$^\circ\text{C}/\text{W}$
T_J, T_{STG}	Operating and Storage Temperature Range		-55 to +175	$^\circ\text{C}$

MOSFET ELECTRICAL CHARACTERISTICS Ta=25 °C unless otherwise specified

Symbol	Parameter	Test Condition	Min.	Typ.	Max.	Units
Off Characteristics						
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	$V_{GS} = 0V, I_D = 250\mu A$	68	-	-	V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 68V, V_{GS} = 0V, T_J = 25^\circ C$	-	-	1	μA
I_{GSS}	Gate to Body Leakage Current	$V_{GS} = \pm 20V, V_{DS} = 0V$	-	-	± 100	nA
On Characteristics						
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250\mu A$	2	3	4	V
$R_{DS(on)}$	Static Drain-Source On-Resistance ^{note3}	$V_{GS} = 10V, I_D = 30A$	-	7.5	9	$m\Omega$
Dynamic Characteristics						
C_{iss}	Input Capacitance	$V_{DS} = 30V, V_{GS} = 0V$ $f = 1.0MHz$	-	4000	-	pF
C_{oss}	Output Capacitance		-	267	-	pF
C_{rss}	Reverse Transfer Capacitance		-	250	-	pF
Q_g	Total Gate Charge	$V_{DS} = 30V, I_D = 30A$ $V_{GS} = 10V$	-	35	-	nC
Q_{gs}	Gate-Source Charge		-	10	-	nC
Q_{gd}	Gate-Drain("Miller") Charge		-	9	-	nC
Switching Characteristics						
$t_{d(on)}$	Turn-On Delay Time	$V_{GS} = 10V, V_{DS} = 30V,$ $R_G = 3\Omega, I_D = 30A$	-	15	-	ns
t_r	Turn-On Rise Time		-	90	-	ns
$t_{d(off)}$	Turn-Off Delay Time		-	45	-	ns
t_f	Turn-Off Fall Time		-	30	-	ns
Drain-Source Diode Characteristics and Maximum Ratings						
I_S	Maximum Continuous Drain to Source Diode Forward Current	-	-	80	A	
I_{SM}	Maximum Pulsed Drain to Source Diode Forward Current	-	-	320	A	
V_{SD}	Drain to Source Diode Forward Voltage	$V_{GS} = 0V, I_{SD} = 30A, T_J = 25^\circ C$	-	-	1.2	V
t_{rr}	Reverse Recovery Time	$I_F = 20A, di/dt = 100A/\mu s$	-	78	-	ns
Q_{rr}	Reverse Recovery Charge		-	51	-	nC

Notes: 1. Repetitive Rating: Pulse width limited by maximum junction temperature

2. EAS condition: $T_J = 25^\circ C, V_{DS} = 30V, V_G = 10V, R_G = 25\Omega, L = 0.5mH, I_{AS} = 21A$

3. Pulse Test: Pulse Width $\leq 300\mu s$, Duty Cycle $\leq 0.5\%$

TYPICAL PERFORMANCE CHARACTERISTICS

Figure 1: Output Characteristics

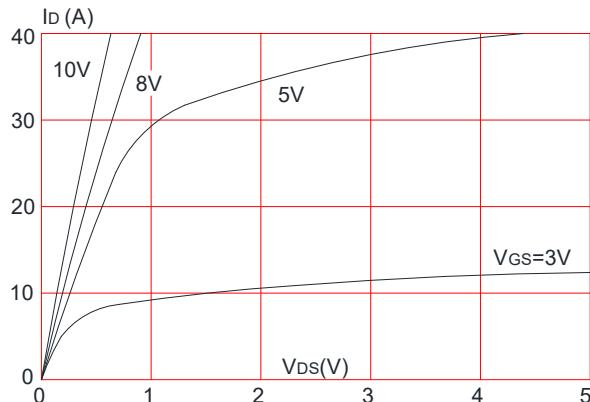


Figure 3: On-resistance vs. Drain Current

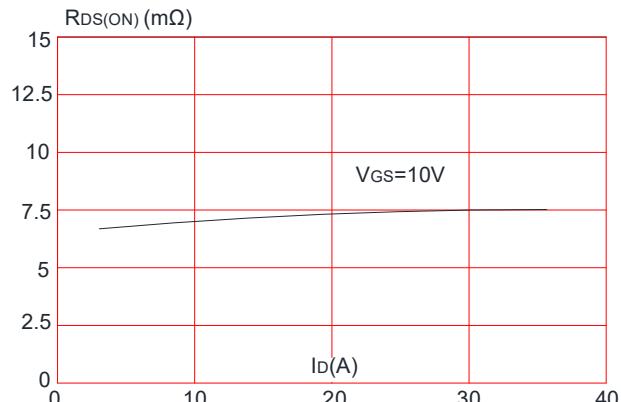


Figure 5: Gate Charge Characteristics

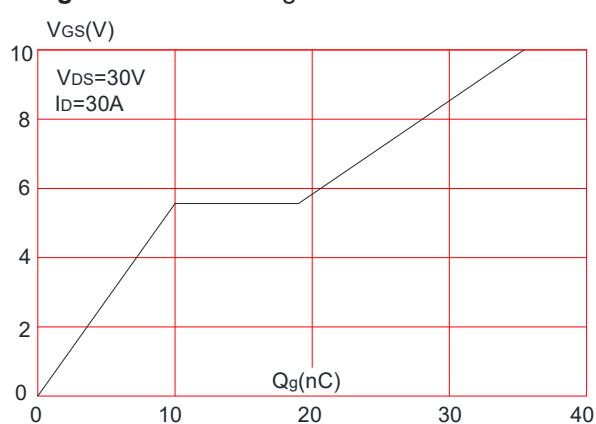


Figure 2: Typical Transfer Characteristics

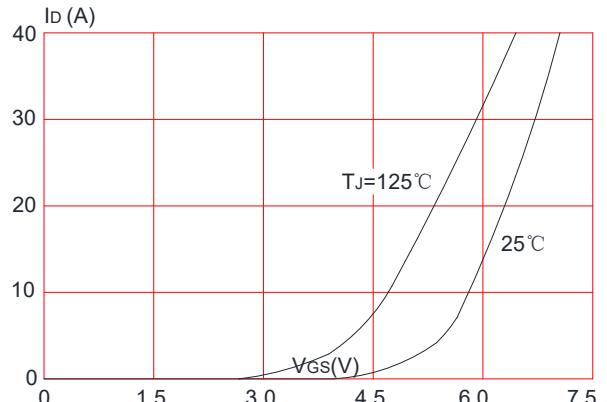


Figure 4: Body Diode Characteristics

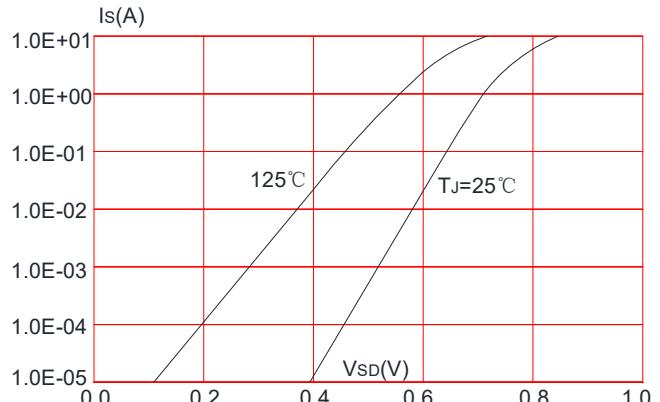


Figure 6: Capacitance Characteristics

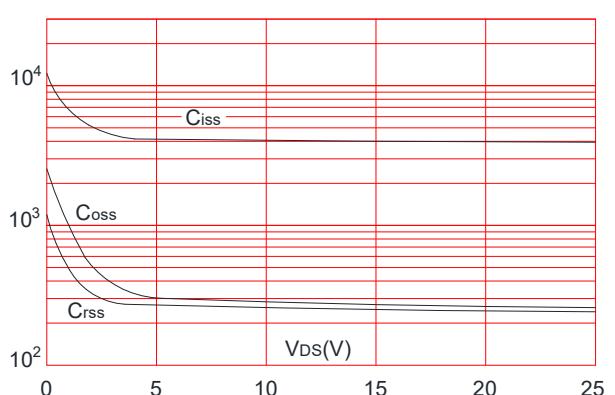


Figure 7: Normalized Breakdown Voltage vs. Junction Temperature

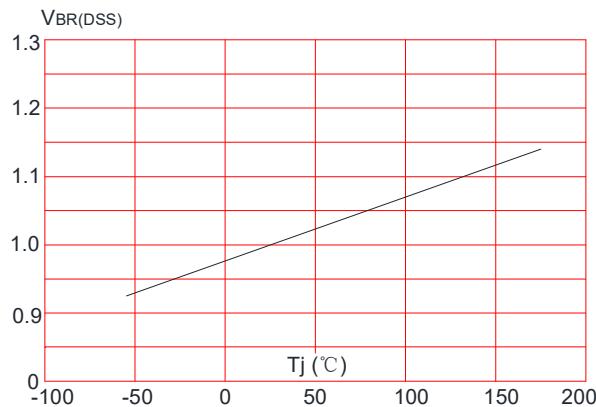


Figure 8: Normalized on Resistance vs. Junction Temperature

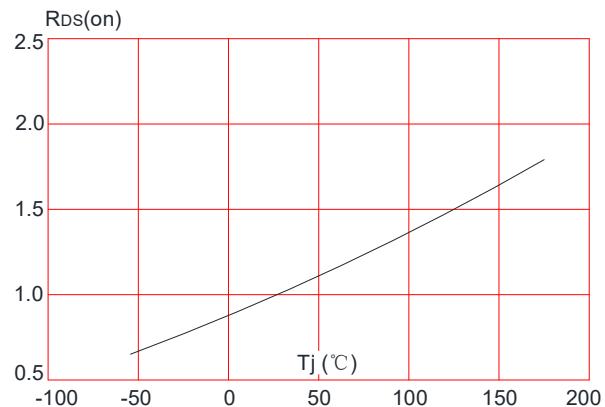


Figure 9: Maximum Safe Operating Area

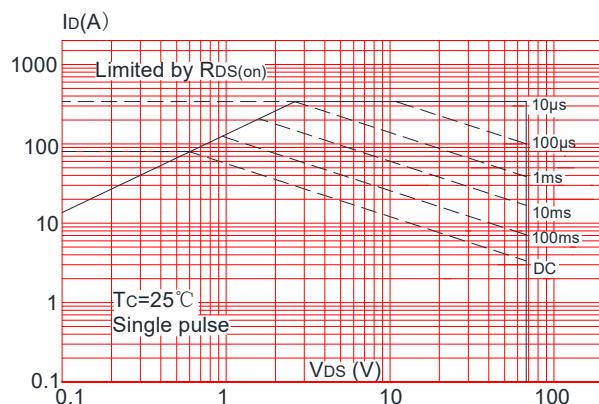


Figure 10: Maximum Continuous Drain Current vs. Case Temperature

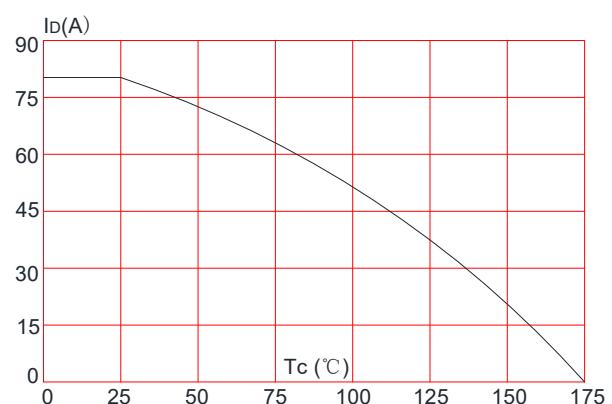
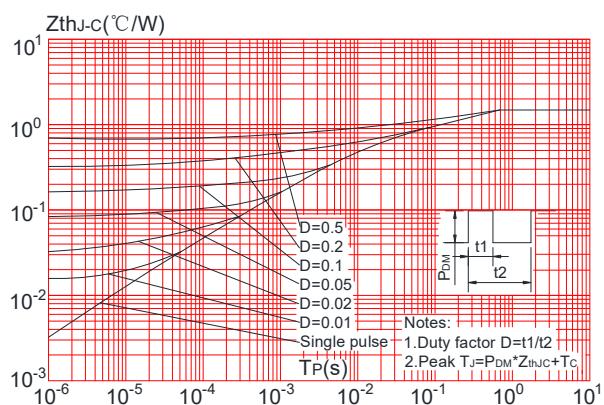
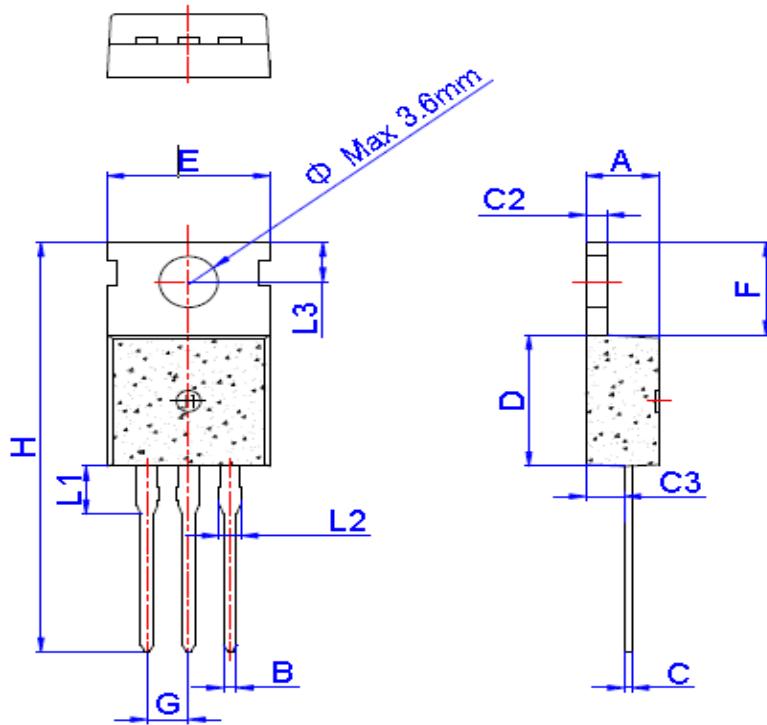


Figure 11: Maximum Effective Transient Thermal Impedance, Junction-to-Case



TO-220 PACKAGE OUTLINE DRAWING



TO-220C

Ref.	Dimensions					
	Millimeters			Inches		
	Min.	Typ.	Max.	Min.	Typ.	Max.
A	4.40		4.60	0.173		0.181
B	0.70		0.90	0.028		0.035
C	0.45		0.60	0.018		0.024
C2	1.23		1.32	0.048		0.052
C3	2.20		2.60	0.087		0.102
D	8.90		9.90	0.350		0.390
E	9.90		10.3	0.390		0.406
F	6.30		6.90	0.248		0.272
G		2.54			0.1	
H	28.0		29.8	1.102		1.173
L1		3.39			0.133	
L2	1.14		1.70	0.045		0.067
L3	2.65		2.95	0.104		0.116
Φ		3.6			0.142	